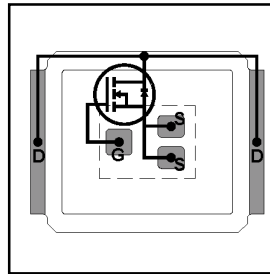


DirectFET™ Power MOSFET

- Application Specific MOSFETs
- Ideal for CPU Core DC-DC Converters
- Low Conduction Losses
- Low Switching Losses
- Low Profile (<0.7 mm)
- Dual Sided Cooling Compatible
- Compatible with existing Surface Mount Techniques

V <sub>DSS</sub>	R <sub>DS(on)</sub> max	I <sub>D</sub>
30V	11.5mΩ@V <sub>GS</sub> = 7.0V	16A
	13mΩ@V <sub>GS</sub> = 4.5V	14A



**Description**

The IRF6604 combines the latest HEXFET® Power MOSFET Silicon technology with the advanced DirectFET™ packaging to achieve the lowest on-state resistance charge product in a package that has the footprint of an SO-8 and only 0.7 mm profile. The DirectFET package is compatible with existing layout geometries used in power applications, PCB assembly equipment and vapor phase, infra-red or convection soldering techniques. The DirectFET package allows dual sided cooling to maximize thermal transfer in power systems, IMPROVING previous best thermal resistance by 80%.

The IRF6604 balances both low resistance and low charge along with ultra low package inductance to reduce both conduction and switching losses. The reduced total losses make this product ideal for high efficiency DC-DC converters that power the latest generation of processors operating at higher frequencies. The IRF6604 has been optimized for parameters that are critical in synchronous buck converters including R<sub>ds(on)</sub> and gate charge to minimize losses in the control FET socket.

**Absolute Maximum Ratings**

	Parameter	Max.	Units
V <sub>DS</sub>	Drain- Source Voltage	30	V
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	59	A
I <sub>D</sub> @ T <sub>A</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	15	
I <sub>D</sub> @ T <sub>A</sub> = 70°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	12.5	
I <sub>DM</sub>	Pulsed Drain Current ①	130	
P <sub>D</sub> @ T <sub>A</sub> = 25°C	Power Dissipation	5.0	W
P <sub>D</sub> @ T <sub>A</sub> = 70°C	Power Dissipation	3.2	
	Linear Derating Factor	40	mW/°C
V <sub>GS</sub>	Gate-to-Source Voltage	±12	V
T <sub>J</sub> , T <sub>STG</sub>	Junction and Storage Temperature Range	-55 to + 150	°C

**Thermal Resistance**

Symbol	Parameter	Typ.	Max.	Units
R <sub>θJA</sub>	Junction-to-Ambient③	—	25	°C/W
R <sub>θJA</sub>	Junction-to-Ambient④	—	12.5	
R <sub>θJA</sub>	Junction-to-Ambient⑤	—	20	
R <sub>θJC</sub>	Junction-to-Case⑥	—	3.0	
R <sub>θJ-PCB</sub>	Junction-to-PCB mounted	—	1.0	

### Static @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
V <sub>(BR)DSS</sub>	Drain-to-Source Breakdown Voltage	30	—	—	V	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250μA
ΔV <sub>(BR)DSS</sub> /ΔT <sub>J</sub>	Breakdown Voltage Temp. Coefficient	—	0.02	—	V/°C	Reference to 25°C, I <sub>D</sub> = 1mA
R <sub>DSS(on)</sub>	Static Drain-to-Source On-Resistance	—	9.0	11.5	mΩ	V <sub>GS</sub> = 7.0V, I <sub>D</sub> = 16A ③
		—	10	13		V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 14A ③
V <sub>GS(th)</sub>	Gate Threshold Voltage	1.0	—	3.0	V	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250μA
I <sub>DSS</sub>	Drain-to-Source Leakage Current	—	—	30	μA	V <sub>DS</sub> = 24V, V <sub>GS</sub> = 0V
		—	—	150		V <sub>DS</sub> = 24V, V <sub>GS</sub> = 0V, T <sub>J</sub> = 100°C
I <sub>GSS</sub>	Gate-to-Source Forward Leakage	—	—	100	nA	V <sub>GS</sub> = 12 V
	Gate-to-Source Reverse Leakage	—	—	-100		V <sub>GS</sub> = -12 V

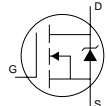
### Dynamic @ T<sub>J</sub> = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
g <sub>fs</sub>	Forward Transconductance	TBA	—	—	S	V <sub>DS</sub> = 16V, I <sub>D</sub> = 15A
Q <sub>g</sub>	Total Gate Charge Cont FET	—	20	30	nC	V <sub>GS</sub> = 5.0V, V <sub>DS</sub> = 16V, I <sub>D</sub> = 15A
Q <sub>g</sub>	Total Gate Charge Sync FET	—	17	—		V <sub>GS</sub> = 5.0V, V <sub>DS</sub> < 100mV
Q <sub>gs1</sub>	Pre-V <sub>th</sub> Gate-Source Charge	—	5.4	—		V <sub>DS</sub> = 16V, I <sub>D</sub> = 15A
Q <sub>gs2</sub>	Post-V <sub>th</sub> Gate-Source Charge	—	1.4	—		
Q <sub>gd</sub>	Gate to Drain Charge	—	7.0	10		
Q <sub>oss</sub>	Output Charge	—	12	—		V <sub>DS</sub> = 16V, V <sub>GS</sub> = 0V
R <sub>g</sub>	Gate Resistance	—	2.0	—	Ω	
t <sub>d(on)</sub>	Turn-On Delay Time	—	TBA	—	ns	V <sub>DD</sub> = 16V
t <sub>r</sub>	Rise Time	—	TBA	—		I <sub>D</sub> = 15A
t <sub>d(off)</sub>	Turn-Off Delay Time	—	TBA	—		V <sub>GS</sub> = 5.0V
t <sub>f</sub>	Fall Time	—	TBA	—		Clamped Inductive Load
C <sub>iss</sub>	Input Capacitance	—	TBA	—	pF	V <sub>GS</sub> = 0V
C <sub>oss</sub>	Output Capacitance	—	TBA	—		V <sub>DS</sub> = 16V ③
C <sub>riss</sub>	Reverse Transfer Capacitance	—	TBA	—		f = 1.0MHz

### Avalanche Characteristics

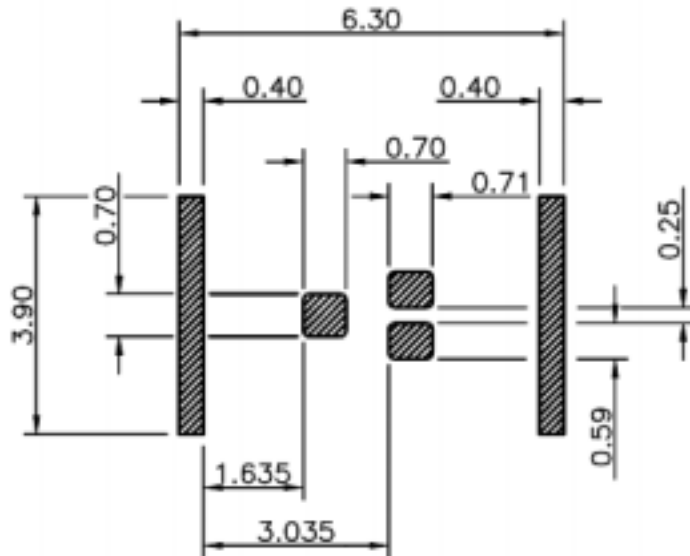
Symbol	Parameter	Typ.	Max.	Units
E <sub>AS</sub>	Single Pulse Avalanche Energy②	—	164	mJ
I <sub>AR</sub>	Avalanche Current①	—	TBA	A

### Diode Characteristics

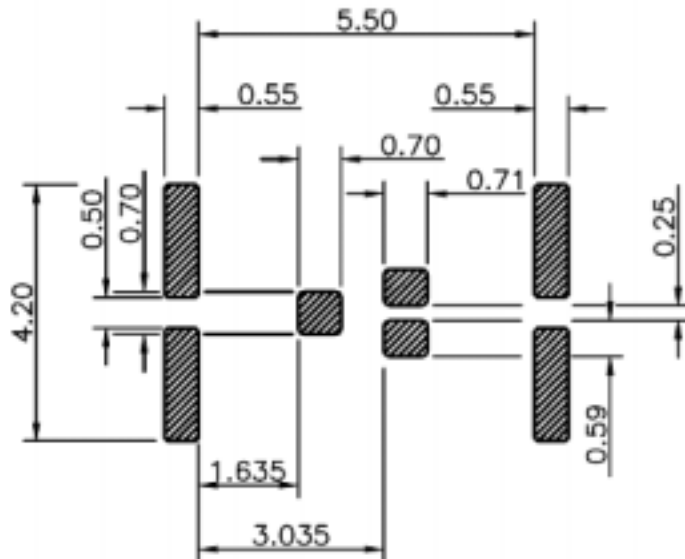
Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
I <sub>S</sub>	Continuous Source Current (Body Diode)	—	—	15	A	MOSFET symbol showing the integral reverse p-n junction diode. 
I <sub>SM</sub>	Pulsed Source Current (Body Diode) ①	—	—	130		
V <sub>SD</sub>	Diode Forward Voltage	—	—	1.2	V	T <sub>J</sub> = 25°C, I <sub>S</sub> = 15A, V <sub>GS</sub> = 0V ③
		—	TBA	—		T <sub>J</sub> = 125°C, I <sub>S</sub> = 15A, V <sub>GS</sub> = 0V ③
t <sub>rr</sub>	Reverse Recovery Time	—	TBA	TBA	ns	T <sub>J</sub> = 25°C, I <sub>F</sub> = 15A, V <sub>R</sub> = 16V
Q <sub>rr</sub>	Reverse Recovery Charge	—	41	50	nC	di/dt = 700A/μs ③
Q <sub>rr(s)</sub>	Reverse Recovery Charge (with Parallel Schottky)	—	TBA	TBA	nC	di/dt = 100A/μs V <sub>DS</sub> = 16V, V <sub>GS</sub> = 0V, I <sub>S</sub> = 15A

DirectFET™ Pad Layout

### Device Pad Layout



### PCB Pad Layout

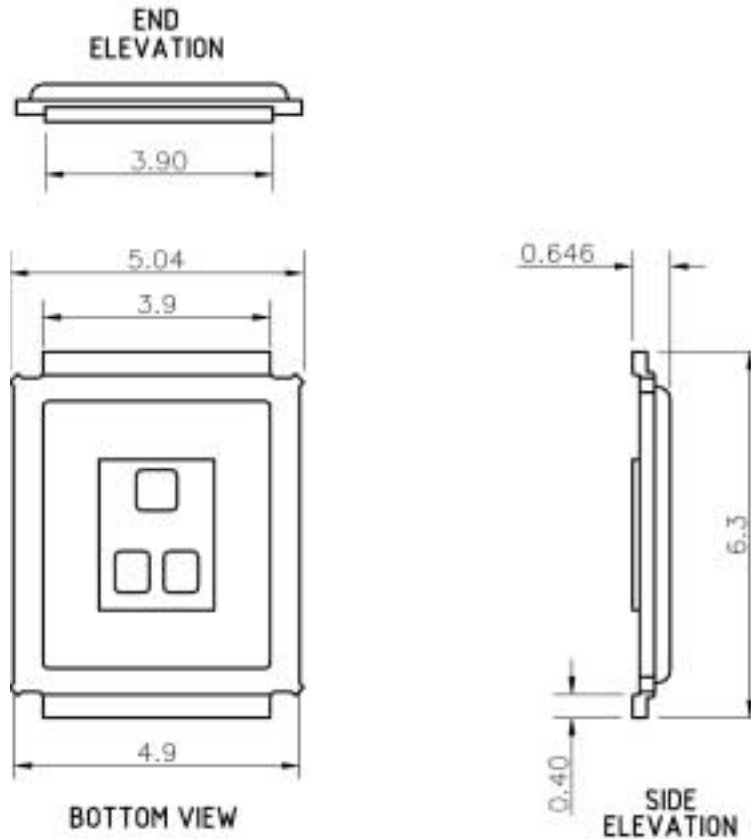


# IRF6604

PROVISIONAL

International  
**IR** Rectifier

## DirectFET™ Outline Dimension



### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Pulse width  $\leq 400\mu\text{s}$ ; duty cycle  $\leq 2\%$ .
- ③ Surface mounted on 1 in square Cu board
- ④ Used double sided cooling, mounting pad
- ⑤ Mounted on minimum footprint full size board with metalized back and with small clip heatsink
- ⑥  $T_C$  measured with thermal couple mounted to top (Drain) of part.

Data and specifications subject to change without notice.  
This product has been designed and qualified for the Consumer market.  
Qualification Standards can be found on IR's Web site.

International  
**IR** Rectifier

IR WORLD HEADQUARTERS: 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105  
TAC Fax: (310) 252-7903

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